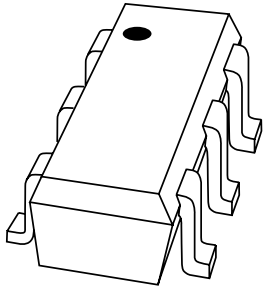


DATA SHEET



BF1205 Dual N-channel dual gate MOS-FET

Product specification

2003 Sep 30

Dual N-channel dual gate MOS-FET

BF1205

FEATURES

- Two low noise gain controlled amplifiers in a single package. One with a fully integrated bias and one with a partly integrated bias
- Internal switch reduces the number of external components
- Superior cross-modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio.

APPLICATIONS

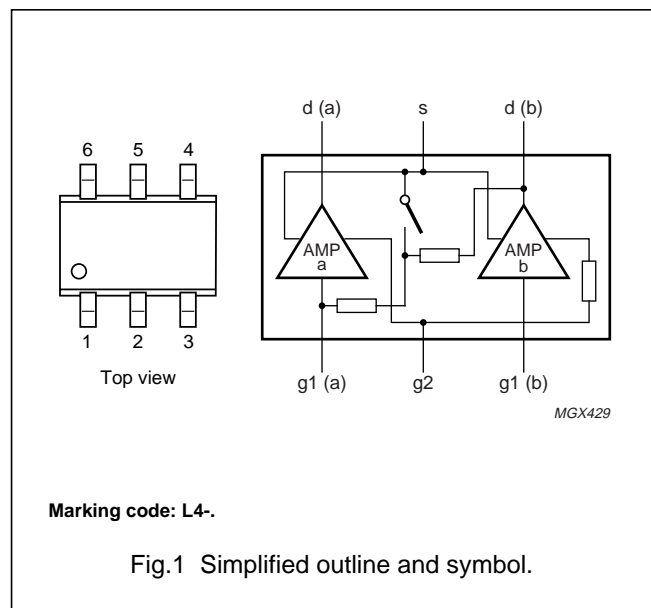
- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage, such as digital and analog television tuners and professional communications equipment.

DESCRIPTION

The BF1205 is a combination of two equal dual gate MOS-FET amplifiers with shared source and gate 2 leads and an integrated switch. The integrated switch is operated by the gate 1 bias of amplifier b. The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross-modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor is encapsulated in SOT363 micro-miniature plastic package.

PINNING - SOT363

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | gate 1 (a) |
| 2 | gate 2 |
| 3 | gate 1 (b) |
| 4 | drain (b) |
| 5 | source |
| 6 | drain (a) |



ORDERING INFORMATION

| TYPE NUMBER | PACKAGE | | |
|-------------|---------|--|---------|
| | NAME | DESCRIPTION | VERSION |
| BF1205 | – | Plastic surface mounted package; 6 leads | SOT363 |

Dual N-channel dual gate MOS-FET

BF1205

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|------------------------------|--|------|------|------|------------------|
| Per MOS-FET; unless otherwise specified | | | | | | |
| V_{DS} | drain-source voltage | | – | – | 10 | V |
| I_D | drain current (DC) | | – | – | 30 | mA |
| P_{tot} | total power dissipation | $T_s \leq 102\text{ }^\circ\text{C}$; temperature at the soldering point of the source lead | – | – | 200 | mW |
| $ y_{fs} $ | forward transfer admittance | $I_D = 12\text{ mA}$ | 26 | 31 | 40 | mS |
| C_{ig1-ss} | input capacitance at gate 1 | amp. a: $f = 1\text{ MHz}$ | – | 1.8 | 2.3 | pF |
| | | amp. b: $f = 1\text{ MHz}$ | – | 2.0 | 2.5 | pF |
| C_{rss} | reverse transfer capacitance | $f = 1\text{ MHz}$ | – | 20 | – | fF |
| NF | noise figure | amp. a: $f = 800\text{ MHz}$ | – | 1.2 | 1.9 | dB |
| | | amp. b: $f = 800\text{ MHz}$ | – | 1.4 | 2.1 | dB |
| X_{mod} | cross-modulation | amp. a: input level for $k = 1\%$ at 40 dB AGC | 98 | 102 | – | dB μ V |
| | | amp. b: input level for $k = 1\%$ at 40 dB AGC | 100 | 105 | – | dB μ V |
| T_j | junction temperature | | – | – | 150 | $^\circ\text{C}$ |

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--|-------------------------|---|------|----------|------------------|
| Per MOS-FET; unless otherwise specified | | | | | |
| V_{DS} | drain-source voltage | | – | 10 | V |
| I_D | drain current (DC) | | – | 30 | mA |
| I_{G1} | gate 1 current | | – | ± 10 | mA |
| I_{G2} | gate 2 current | | – | ± 10 | mA |
| P_{tot} | total power dissipation | $T_s \leq 102\text{ }^\circ\text{C}$; note | – | 200 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

- T_s is the temperature at the soldering point of the source lead.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 240 | K/W |

Dual N-channel dual gate MOS-FET

BF1205

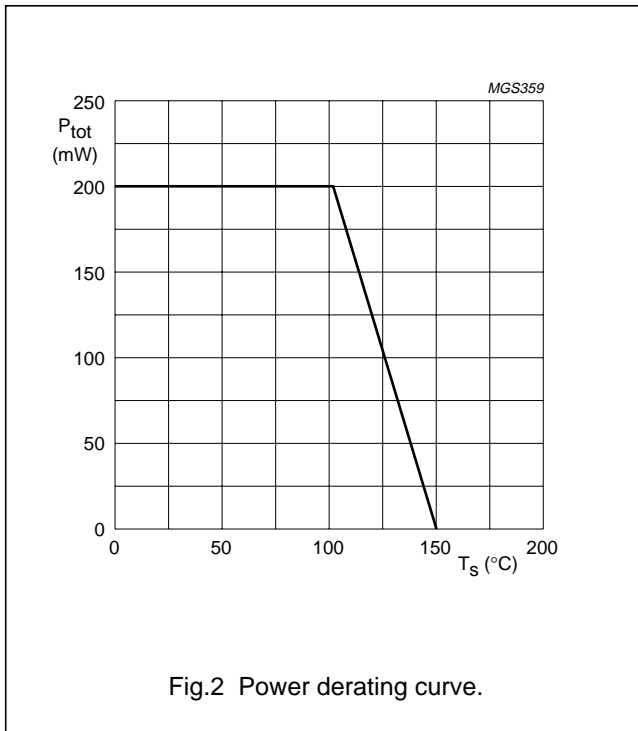


Fig.2 Power derating curve.

STATIC CHARACTERISTICS $T_j = 25$ $^{\circ}\text{C}$; per MOS-FET; unless otherwise specified.

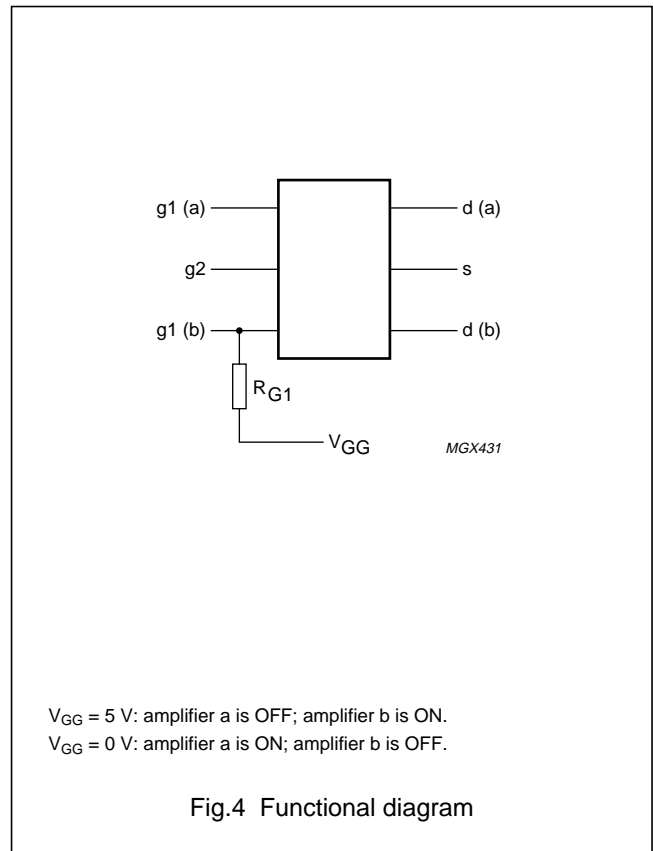
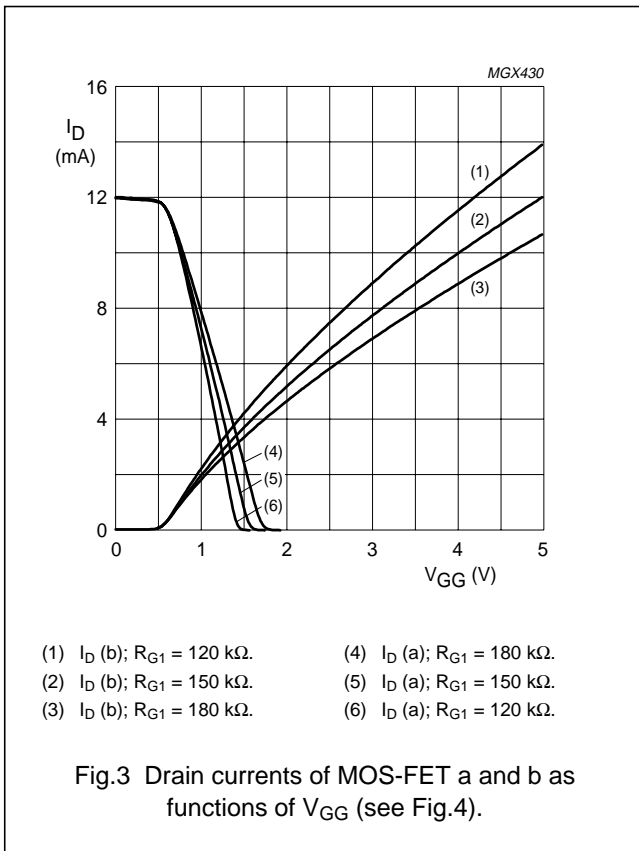
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------------|--------------------------------|--|------|------|------|
| $V_{(BR)DS}$ | drain-source breakdown voltage | amp. a: $V_{G1-S} = V_{G2-S} = 0$ V; $I_D = 10$ μA | 10 | – | V |
| | | amp. b: $V_{G1-S} = V_{G2-S} = 0$ V; $I_D = 10$ μA | 7 | – | V |
| $V_{(BR)G1-SS}$ | gate-source breakdown voltage | $V_{GS} = V_{DS} = 0$ V; $I_{G1-S} = 10$ mA | 6 | 10 | V |
| $V_{(BR)G2-SS}$ | gate-source breakdown voltage | $V_{GS} = V_{DS} = 0$ V; $I_{G2-S} = 10$ mA | 6 | 10 | V |
| $V_{(F)S-G1}$ | forward source-gate voltage | $V_{G2-S} = V_{DS} = 0$ V; $I_{S-G1} = 10$ mA | 0.5 | 1.5 | V |
| $V_{(F)S-G2}$ | forward source-gate voltage | $V_{G1-S} = V_{DS} = 0$ V; $I_{S-G2} = 10$ mA | 0.5 | 1.5 | V |
| $V_{G1-S(th)}$ | gate-source threshold voltage | $V_{DS} = 5$ V; $V_{G2-S} = 4$ V; $I_D = 100$ μA | 0.3 | 1 | V |
| $V_{G2-S(th)}$ | gate-source threshold voltage | $V_{DS} = 5$ V; $V_{G1-S} = 5$ V; $I_D = 100$ μA | 0.4 | 1.0 | V |
| I_{DSX} | drain-source current | amp. a: $V_{G2-S} = 4$ V; $V_{DS} = 5$ V; $R_{G1} = 150$ k Ω ; note 1 | 8 | 16 | mA |
| | | amp. b: $V_{G2-S} = 4$ V; $V_{DS} = 5$ V; $R_{G1} = 150$ k Ω ; note 2 | 8 | 16 | mA |
| I_{G1-S} | gate cut-off current | amp. a: $V_{G1-S} = 5$ V; $V_{G2-S} = V_{DS} = 0$ V | – | 50 | nA |
| | | amp. b: $V_{G1-S} = 5$ V; $V_{G2-S} = V_{DS} = 0$ V | – | 50 | nA |
| I_{G2-S} | gate cut-off current | $V_{G2-S} = 4$ V; $V_{G1-S} = V_{DS} = 0$ V | – | 20 | nA |

Note

- R_{G1} connects gate 1 (b) to $V_{GG} = 0$ V (see Fig.4).
- R_{G1} connects gate 1 (b) to $V_{GG} = 5$ V (see Fig.4).

Dual N-channel dual gate MOS-FET

BF1205



Dual N-channel dual gate MOS-FET

BF1205

DYNAMIC CHARACTERISTICS AMPLIFIER aCommon source; $T_{amb} = 25\text{ °C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 12\text{ mA}$; note 1

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|------------------------------|---|------|------|------|------------|
| $ y_{fs} $ | forward transfer admittance | $T_j = 25\text{ °C}$ | 26 | 31 | 40 | mS |
| C_{ig1-ss} | input capacitance at gate 1 | $f = 1\text{ MHz}$ | – | 1.8 | 2.3 | pF |
| C_{ig2-ss} | input capacitance at gate 2 | $f = 1\text{ MHz}$ | – | 3.3 | – | pF |
| C_{oss} | output capacitance | $f = 1\text{ MHz}$ | – | 0.75 | – | pF |
| C_{rss} | reverse transfer capacitance | $f = 1\text{ MHz}$ | – | 20 | – | fF |
| G_{tr} | power gain | $f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 0.5\text{ mS}$; $B_L = B_{L(opt)}$ | 31 | 35 | 39 | dB |
| | | $f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 1\text{ mS}$; $B_L = B_{L(opt)}$ | 27 | 31 | 35 | dB |
| | | $f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 1\text{ mS}$; $B_L = B_{L(opt)}$ | 22 | 26 | 30 | dB |
| NF | noise figure | $f = 10.7\text{ MHz}$; $G_S = 20\text{ mS}$; $B_S = 0$ | – | 4 | – | dB |
| | | $f = 400\text{ MHz}$; $Y_S = Y_{S(opt)}$ | – | 1.1 | 1.7 | dB |
| | | $f = 800\text{ MHz}$; $Y_S = Y_{S(opt)}$ | – | 1.2 | 1.9 | dB |
| X_{mod} | cross-modulation | input level for $k = 1\%$ at 0 dB AGC; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$; note 2 | 90 | – | – | dB μ V |
| | | input level for $k = 1\%$ at 10 dB AGC; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$; note 2 | – | 90 | – | dB μ V |
| | | input level for $k = 1\%$ at 40 dB AGC; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$; note 2 | 98 | 102 | – | dB μ V |

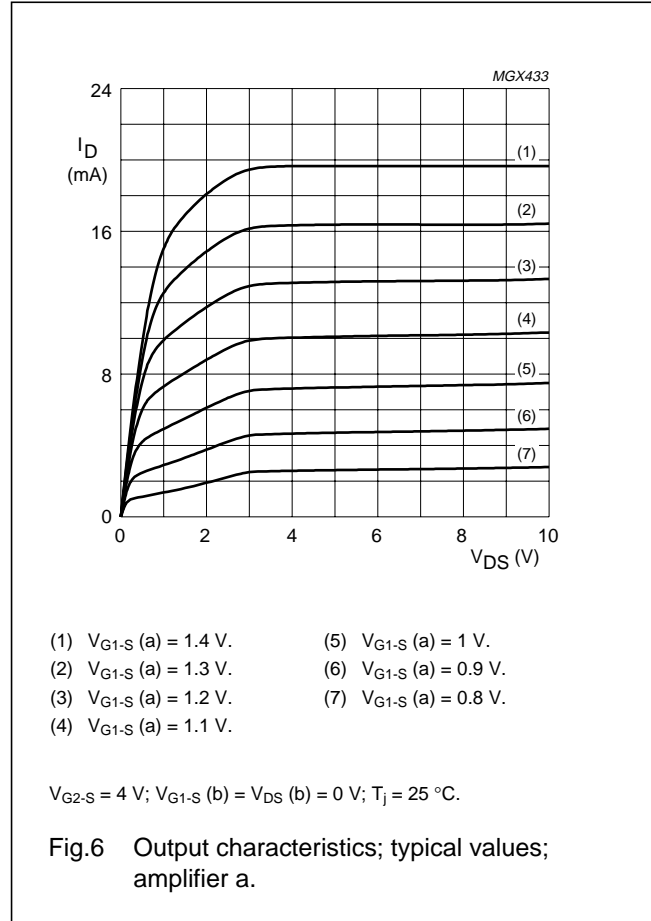
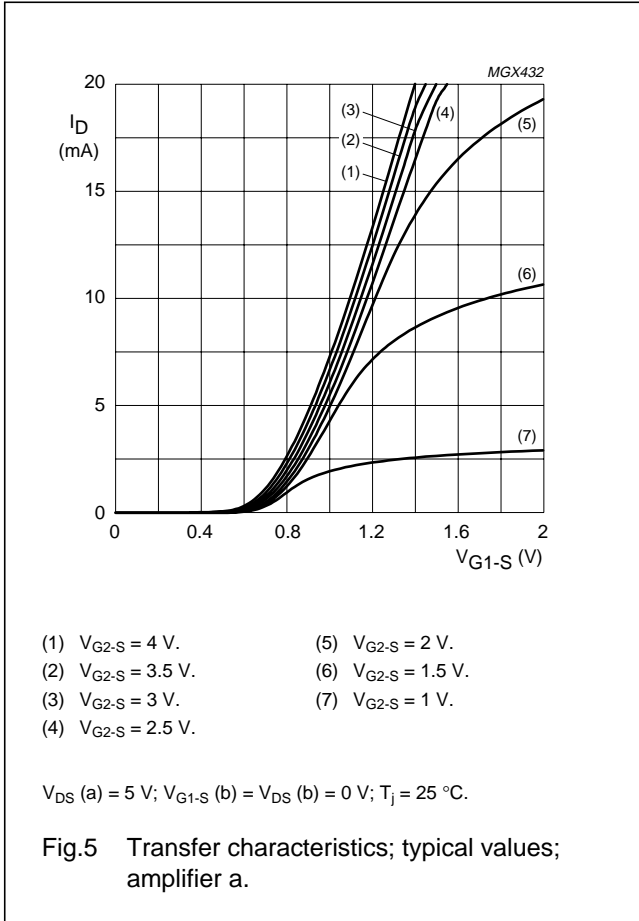
Notes

1. For the MOS-FET not in use: $V_{G1-S} (b) = 0\text{ V}$; $V_{DS} (b) = 0\text{ V}$.
2. Measured in Fig.13 test circuit.

Dual N-channel dual gate MOS-FET

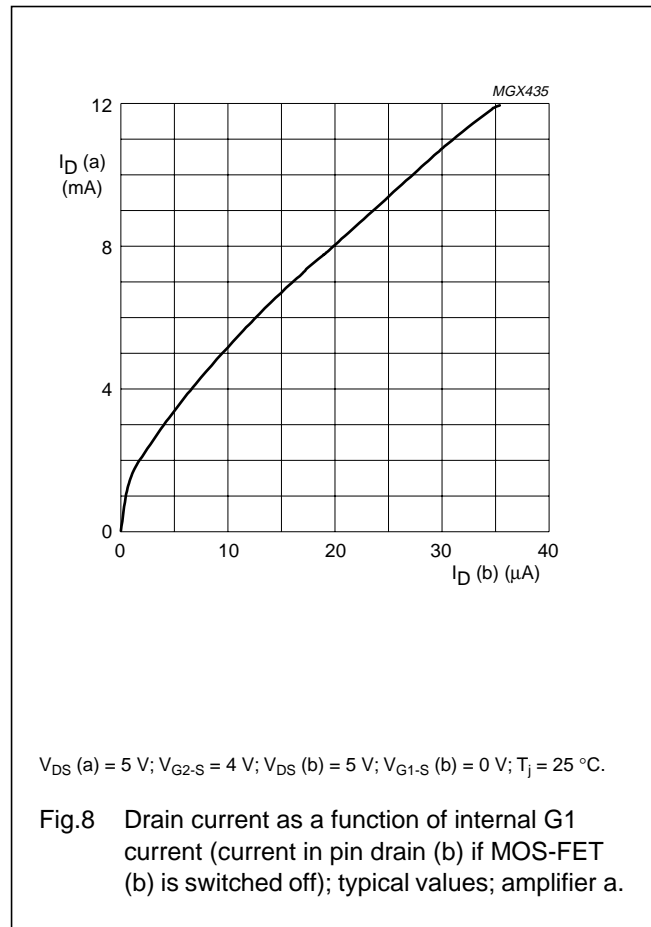
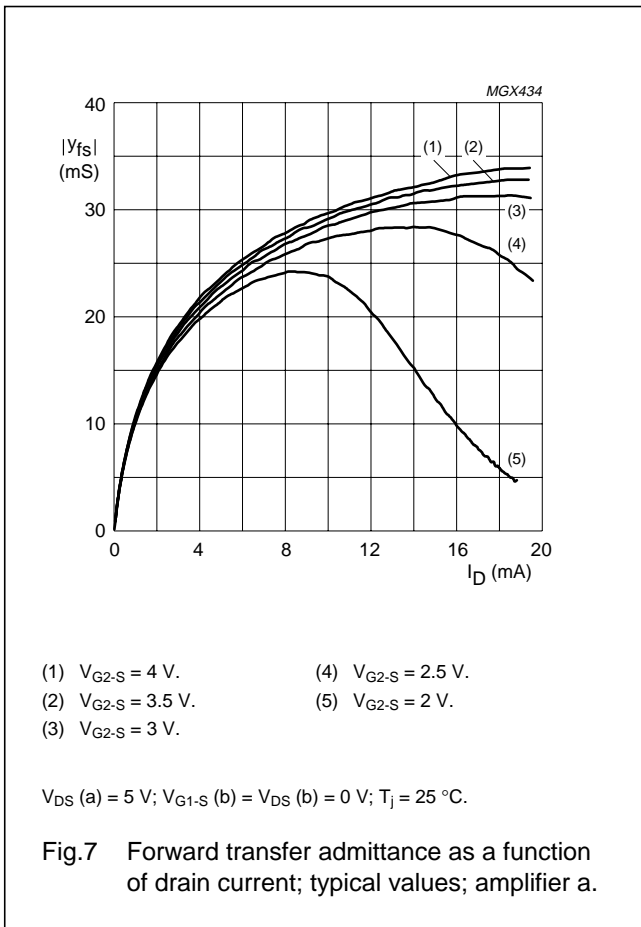
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GRAPHS FOR AMPLIFIER a



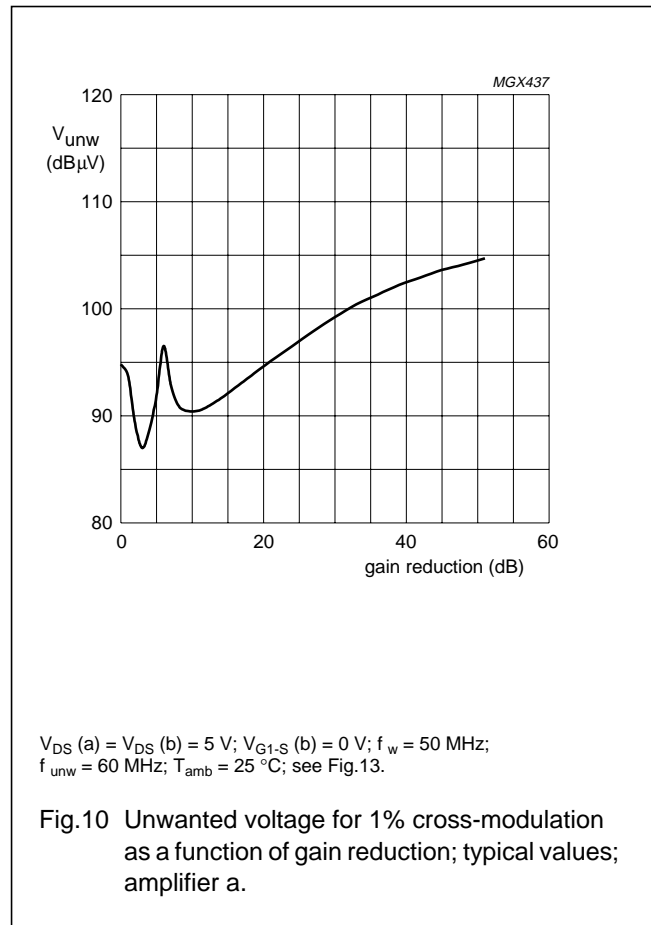
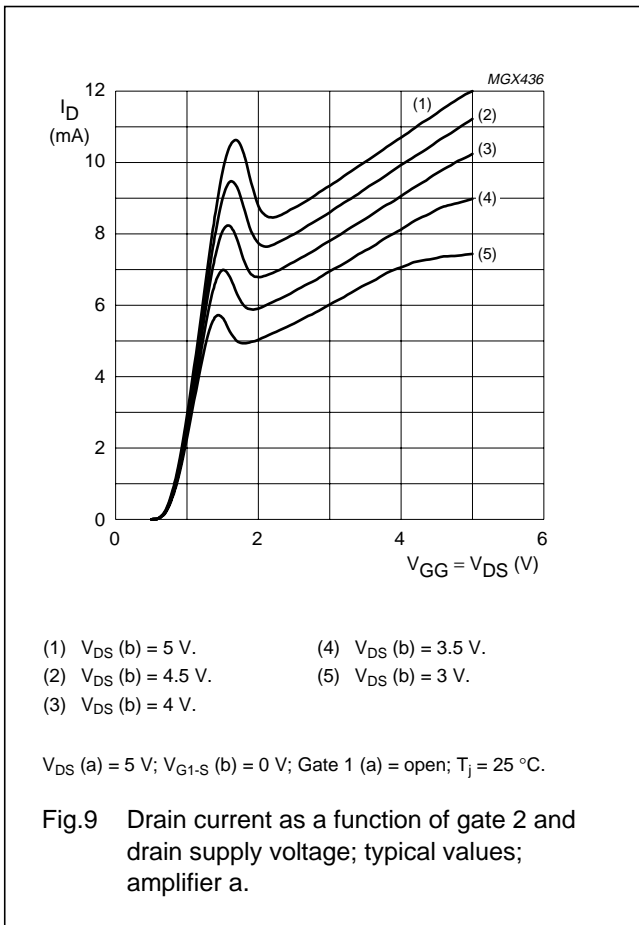
Dual N-channel dual gate MOS-FET

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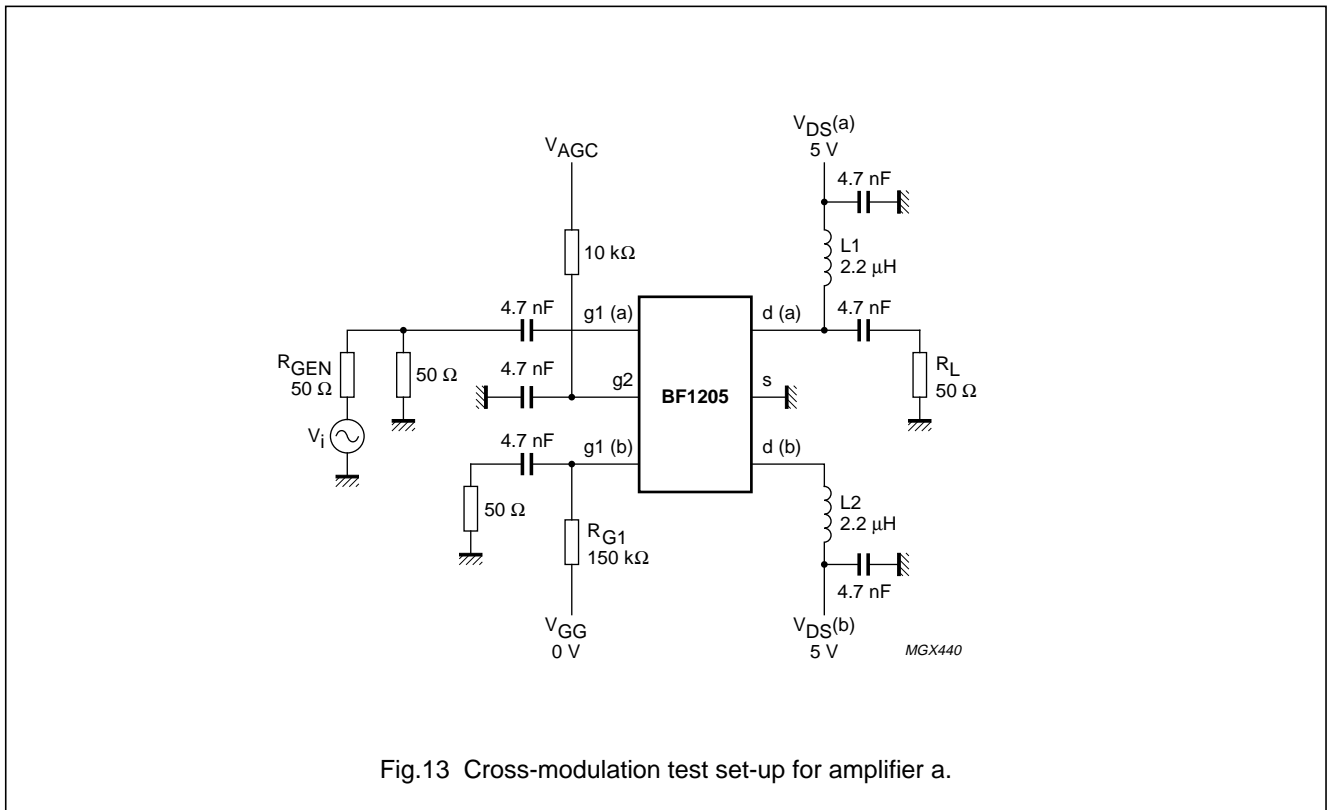
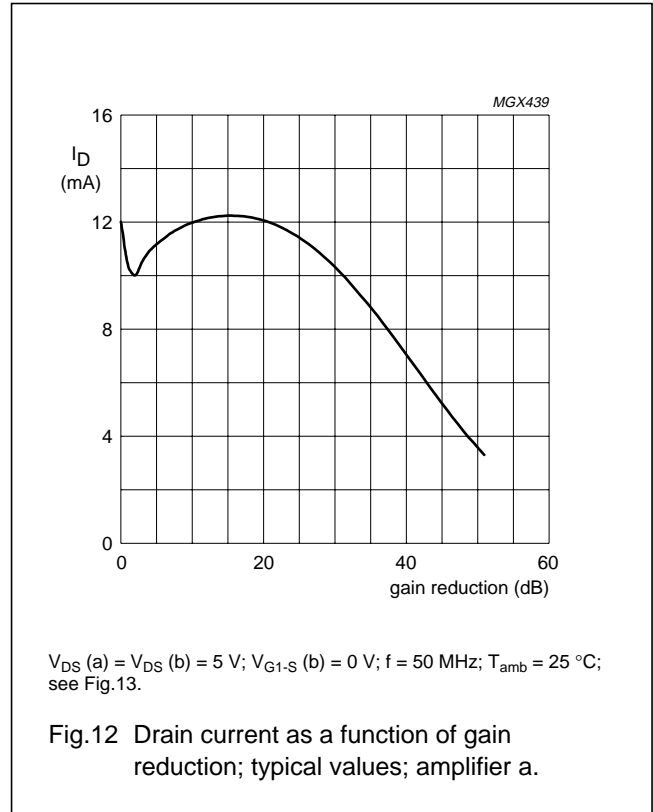
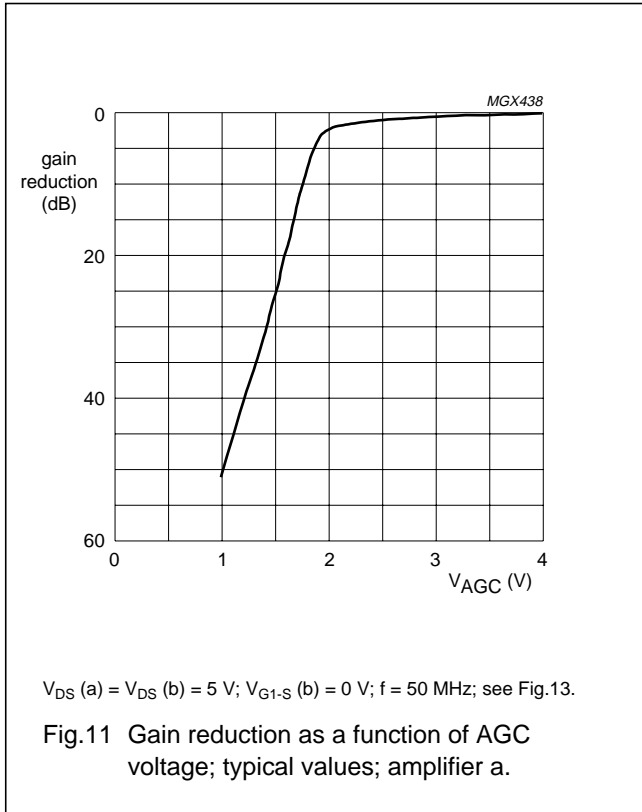
Dual N-channel dual gate MOS-FET

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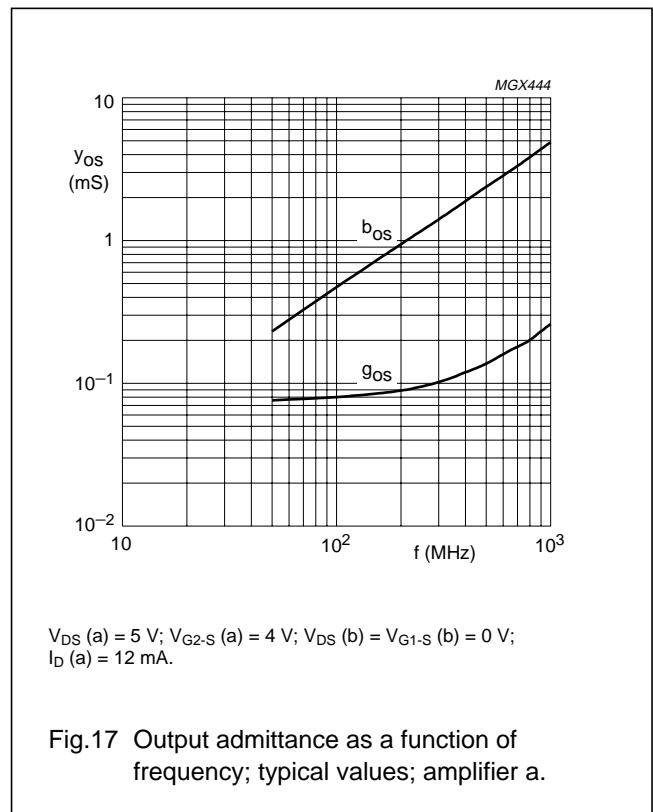
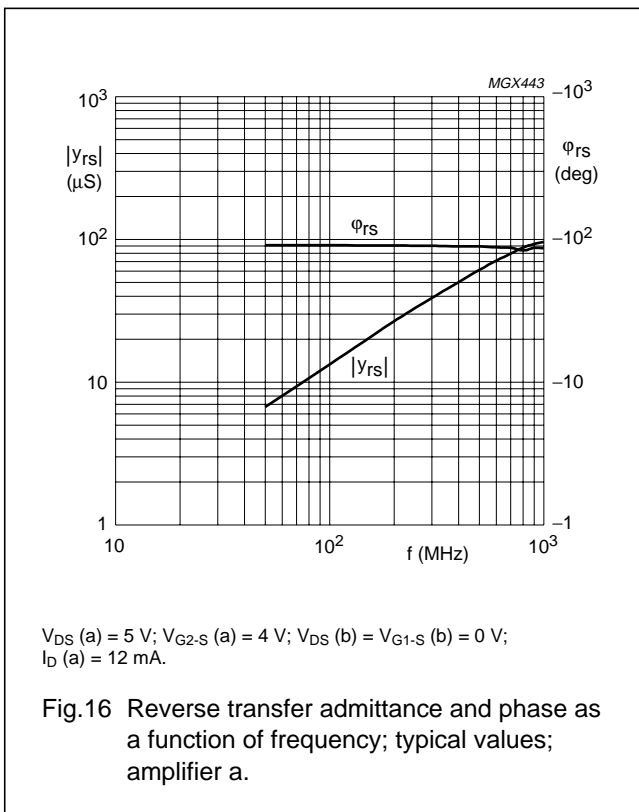
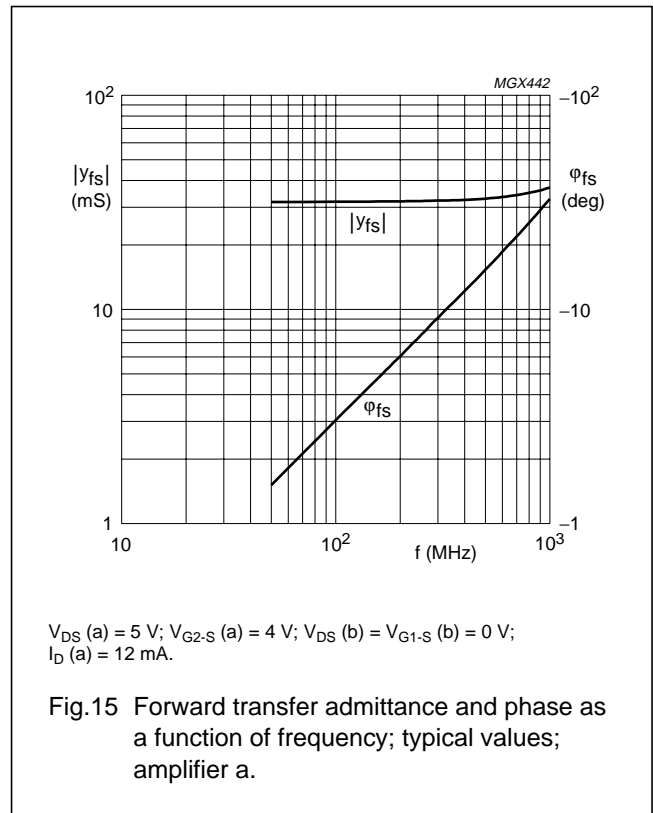
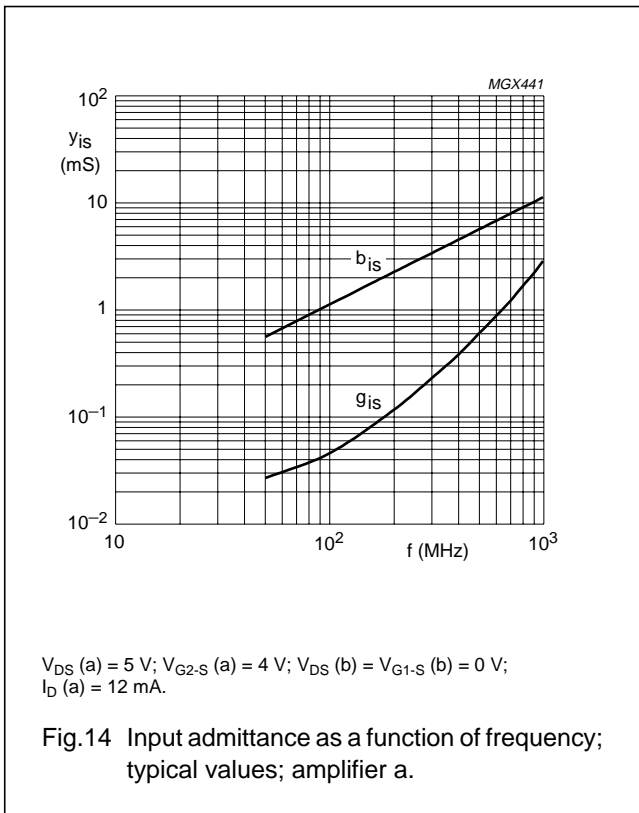
Dual N-channel dual gate MOS-FET

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Dual N-channel dual gate MOS-FET

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Dual N-channel dual gate MOS-FET

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Scattering parameters: amplifier a

 $V_{DS} (a) = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D (a) = 12 \text{ mA}$; $V_{DS} (b) = 0 \text{ V}$; $V_{G-1S} (b) = 0 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) |
| 50 | 0.997 | -3.70 | 3.15 | 175.99 | 0.00067 | 86.39 | 0.992 | -1.38 |
| 100 | 0.995 | -7.37 | 3.15 | 171.92 | 0.00132 | 84.34 | 0.991 | -2.83 |
| 200 | 0.988 | -14.64 | 3.12 | 163.99 | 0.00262 | 79.71 | 0.990 | -5.62 |
| 300 | 0.976 | -21.85 | 3.09 | 156.06 | 0.00373 | 75.29 | 0.988 | -8.40 |
| 400 | 0.963 | -28.95 | 3.04 | 148.32 | 0.00471 | 71.43 | 0.985 | -11.15 |
| 500 | 0.944 | -35.98 | 2.99 | 140.52 | 0.00557 | 66.89 | 0.982 | -13.88 |
| 600 | 0.924 | -42.90 | 2.94 | 132.88 | 0.00624 | 63.52 | 0.978 | -16.65 |
| 700 | 0.900 | -49.77 | 2.87 | 125.30 | 0.00669 | 60.09 | 0.975 | -19.35 |
| 800 | 0.874 | -56.61 | 2.81 | 117.79 | 0.00701 | 59.58 | 0.972 | -22.08 |
| 900 | 0.846 | -63.18 | 2.73 | 110.29 | 0.00705 | 52.42 | 0.968 | -24.87 |
| 1000 | 0.817 | -69.84 | 2.65 | 102.91 | 0.00688 | 49.17 | 0.965 | -27.63 |

Noise data

 $V_{DS} (a) = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D (a) = 12 \text{ mA}$; $V_{DS} (b) = 0 \text{ V}$; $V_{G-1S} (b) = 0 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$

| f (MHz) | F MIN (dB) | GAMMA OPT | | Rn (Ω) |
|------------|---------------|-----------|-------|--------------------|
| | | (ratio) | (deg) | |
| 400 | 1.1 | 0.719 | 16.16 | 31.18 |
| 800 | 1.2 | 0.628 | 32.7 | 29.74 |

DYNAMIC CHARACTERISTICS AMPLIFIER b

Common source; $T_{amb} = 25 \text{ }^\circ\text{C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 12 \text{ mA}$

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|------------------------------|---|------|------|------|------|
| $ y_{fs} $ | forward transfer admittance | $T_j = 25 \text{ }^\circ\text{C}$ | 26 | 31 | 40 | mS |
| C_{ig1-ss} | input capacitance at gate 1 | $f = 1 \text{ MHz}$ | – | 2.0 | 2.5 | pF |
| C_{ig2-ss} | input capacitance at gate 2 | $f = 1 \text{ MHz}$ | – | 3.3 | – | pF |
| C_{oss} | output capacitance | $f = 1 \text{ MHz}$ | – | 0.85 | – | pF |
| C_{rss} | reverse transfer capacitance | $f = 1 \text{ MHz}$ | – | 20 | – | fF |
| G_{tr} | power gain | $f = 200 \text{ MHz}$; $G_S = 2 \text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 0.5 \text{ mS}$; $B_L = B_{L(opt)}$; note 1 | 30 | 34 | 38 | dB |
| | | $f = 400 \text{ MHz}$; $G_S = 2 \text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 1 \text{ mS}$; $B_L = B_{L(opt)}$; note 1 | 27 | 31 | 35 | dB |
| | | $f = 800 \text{ MHz}$; $G_S = 3.3 \text{ mS}$; $B_S = B_{S(opt)}$; $G_L = 1 \text{ mS}$; $B_L = B_{L(opt)}$; note 1 | 22 | 26 | 30 | dB |
| NF | noise figure | $f = 10.7 \text{ MHz}$; $G_S = 20 \text{ mS}$; $B_S = 0$ | – | 4 | – | dB |
| | | $f = 400 \text{ MHz}$; $Y_S = Y_{S(opt)}$ | – | 1.3 | 1.9 | dB |
| | | $f = 800 \text{ MHz}$; $Y_S = Y_{S(opt)}$ | – | 1.4 | 2.1 | dB |

Dual N-channel dual gate MOS-FET

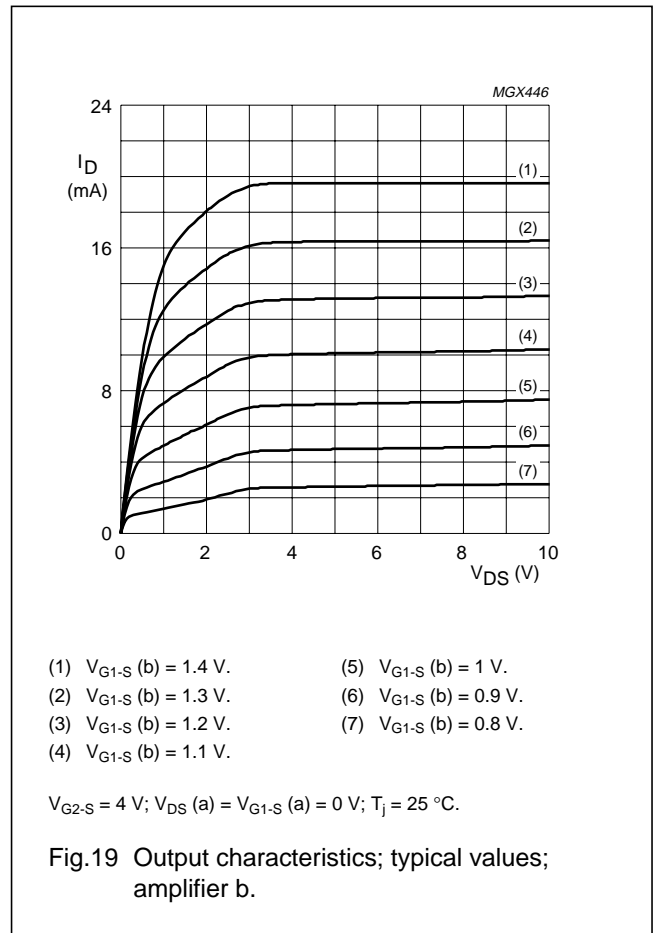
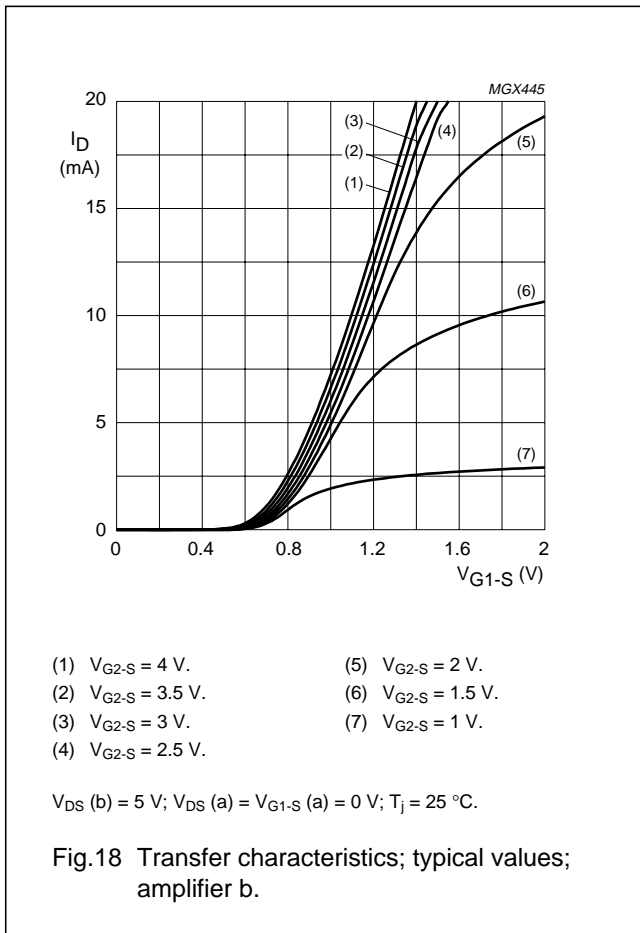
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| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|------------------|---|------|------|------|------------------------|
| X_{mod} | cross-modulation | input level for $k = 1\%$ at 0 dB AGC; $f_w = 50$ MHz; $f_{unw} = 60$ MHz; note 2 | 90 | – | – | $\text{dB}\mu\text{V}$ |
| | | input level for $k = 1\%$ at 10 dB AGC; $f_w = 50$ MHz; $f_{unw} = 60$ MHz; note 2 | – | 92 | – | $\text{dB}\mu\text{V}$ |
| | | input level for $k = 1\%$ at 40 dB AGC; $f_w = 50$ MHz; $f_{unw} = 60$ MHz; note 2 | 100 | 105 | – | $\text{dB}\mu\text{V}$ |

Notes

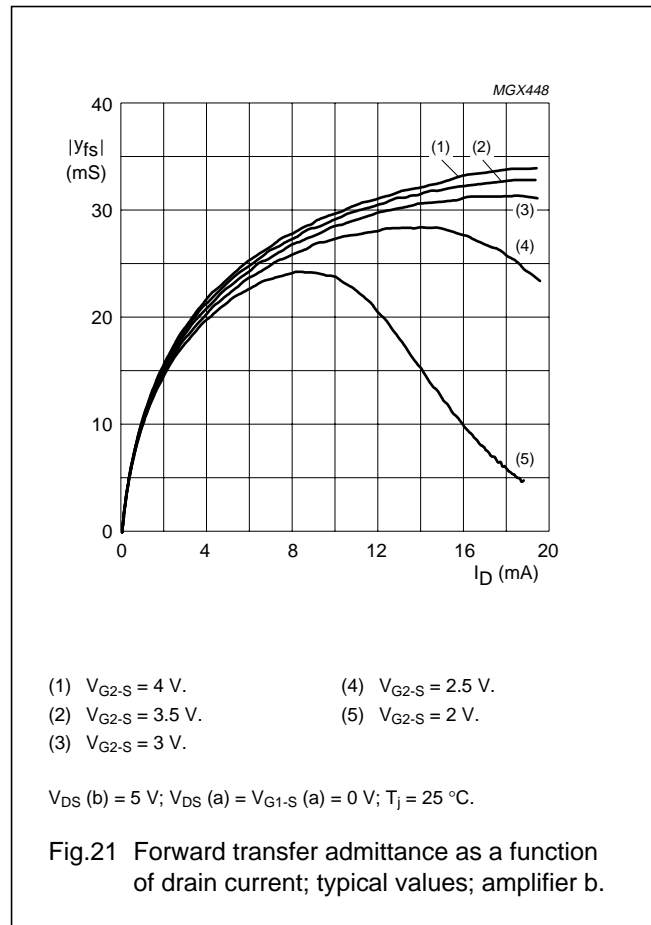
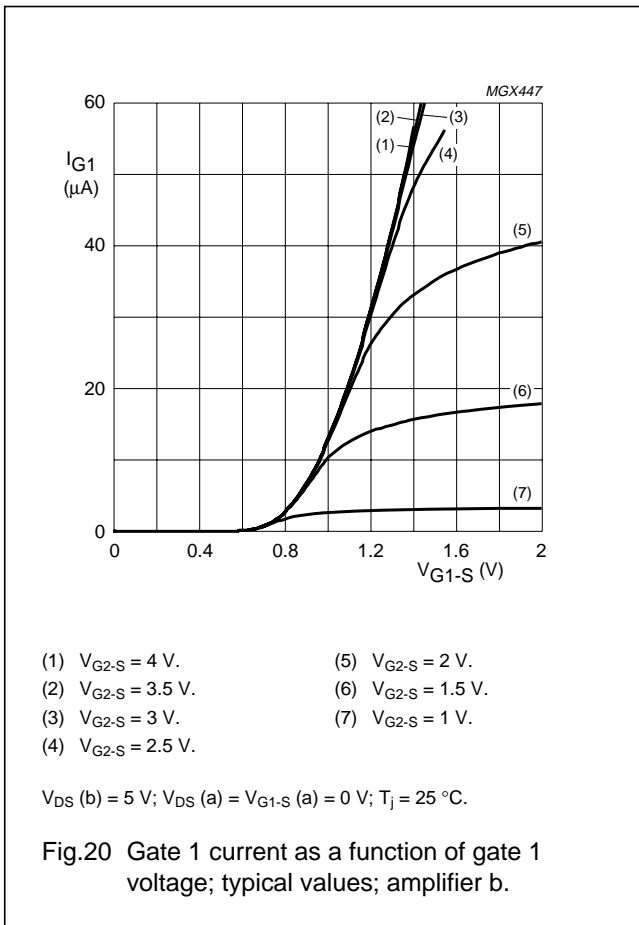
- For the MOS-FET not in use: $V_{G1-S} (a) = 0$; $V_{DS} (a) = 0$.
- Measured in test circuit Fig.30.

GRAPHS FOR AMPLIFIER b



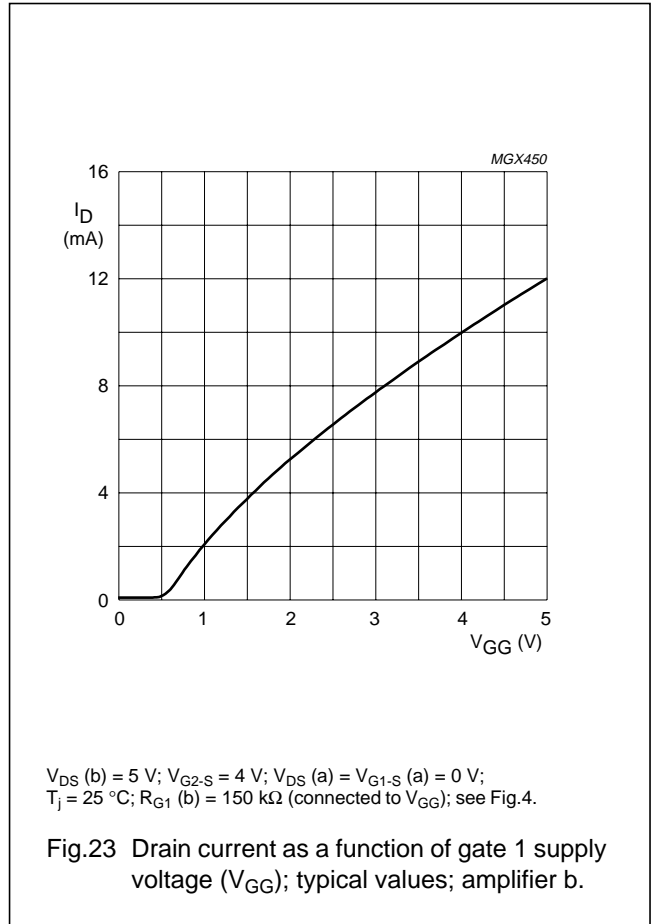
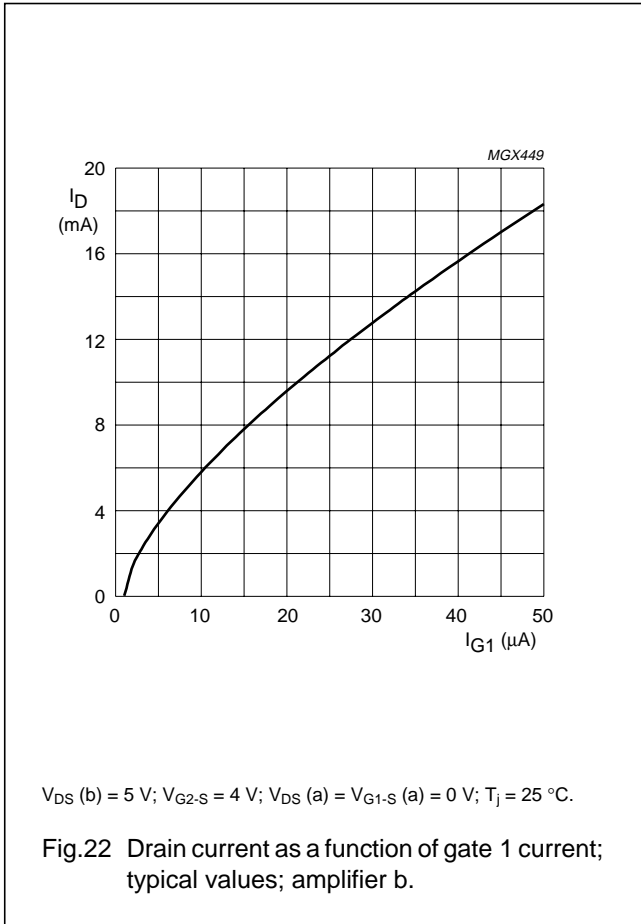
Dual N-channel dual gate MOS-FET

BF1205



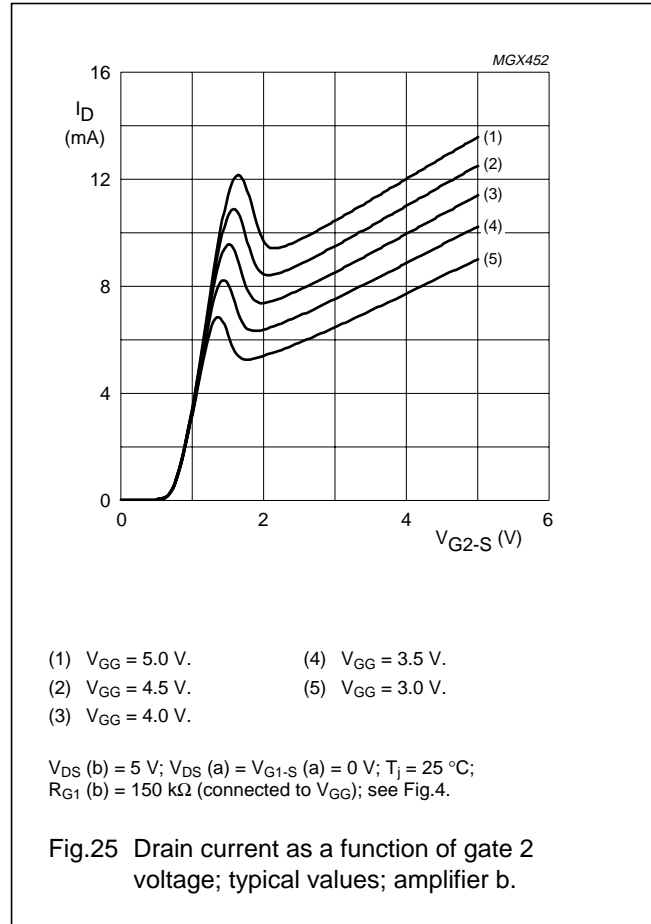
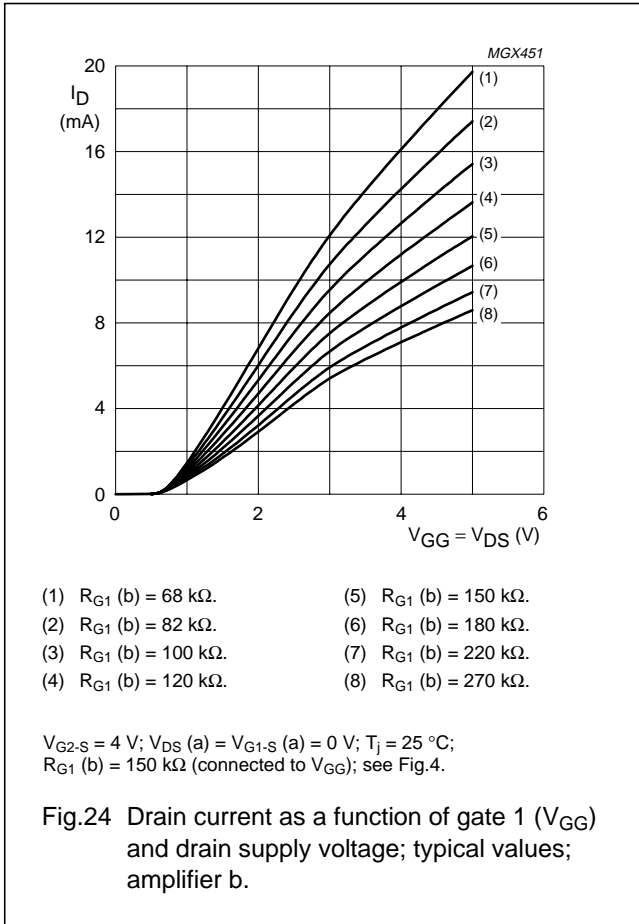
Dual N-channel dual gate MOS-FET

BF1205



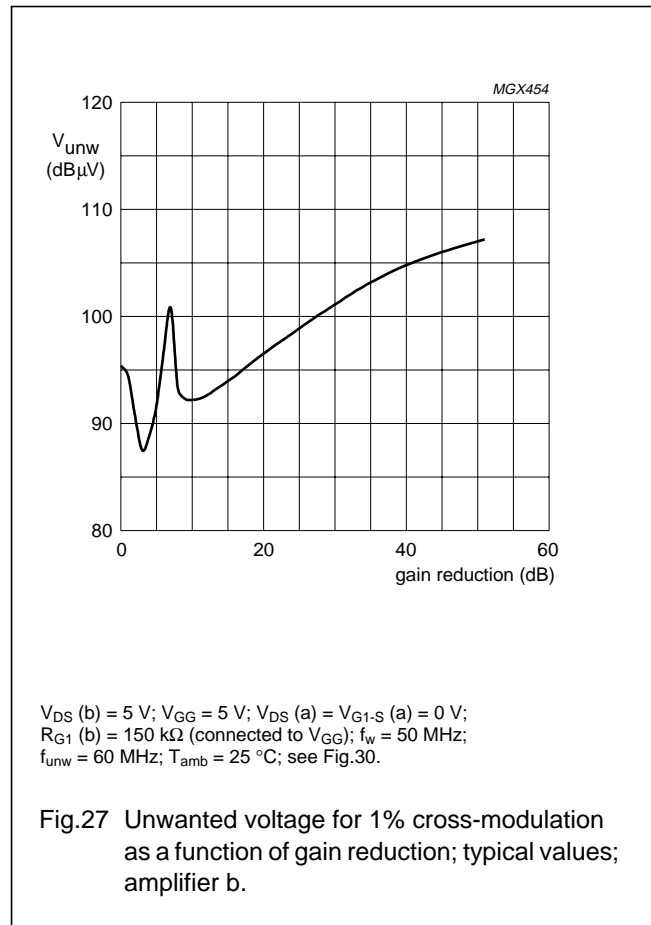
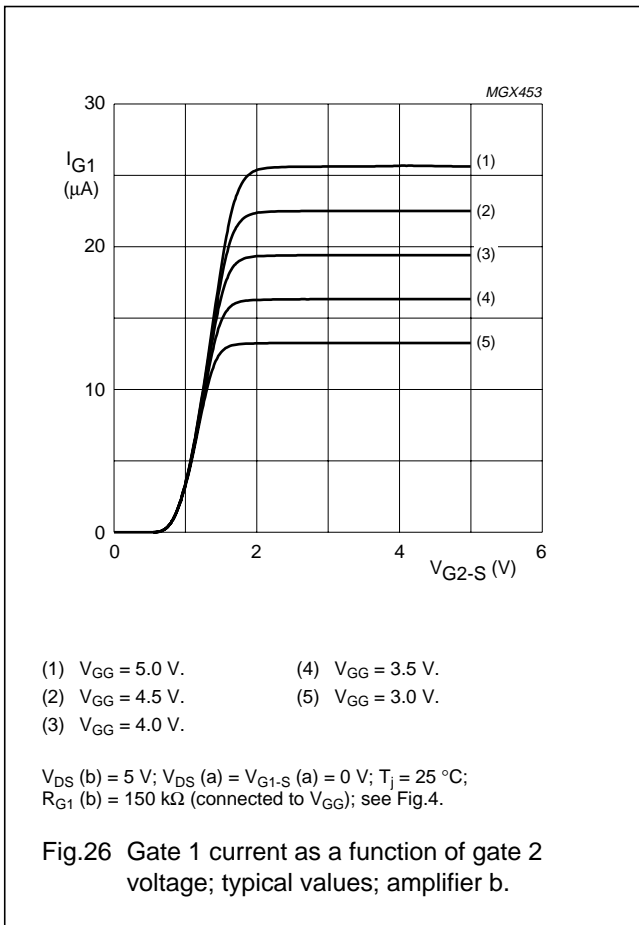
Dual N-channel dual gate MOS-FET

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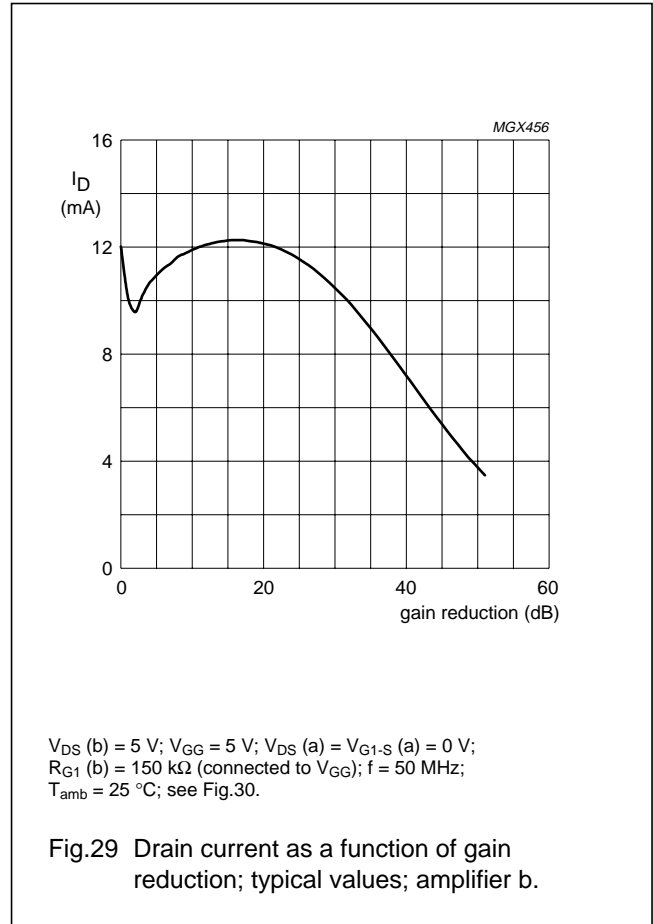
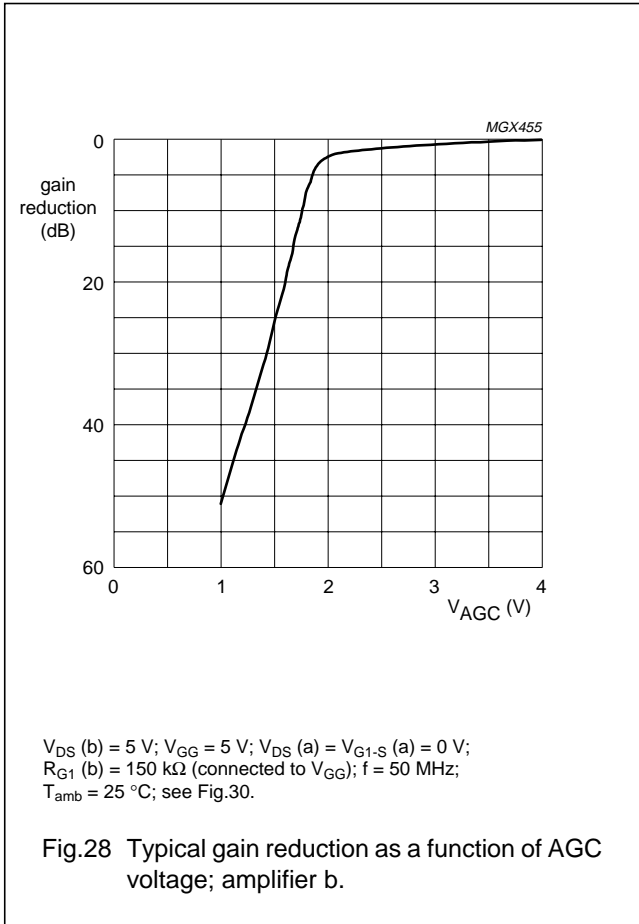
Dual N-channel dual gate MOS-FET

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Dual N-channel dual gate MOS-FET

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Dual N-channel dual gate MOS-FET

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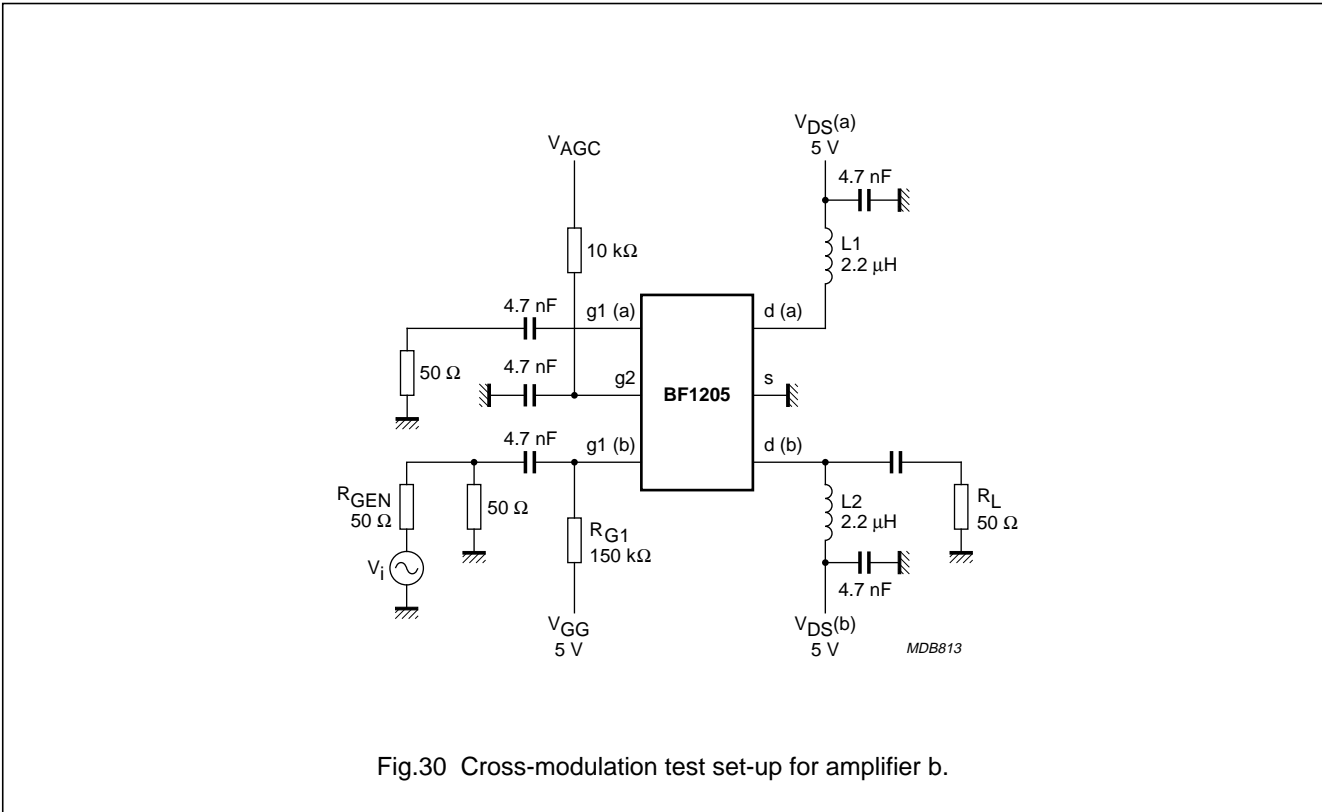
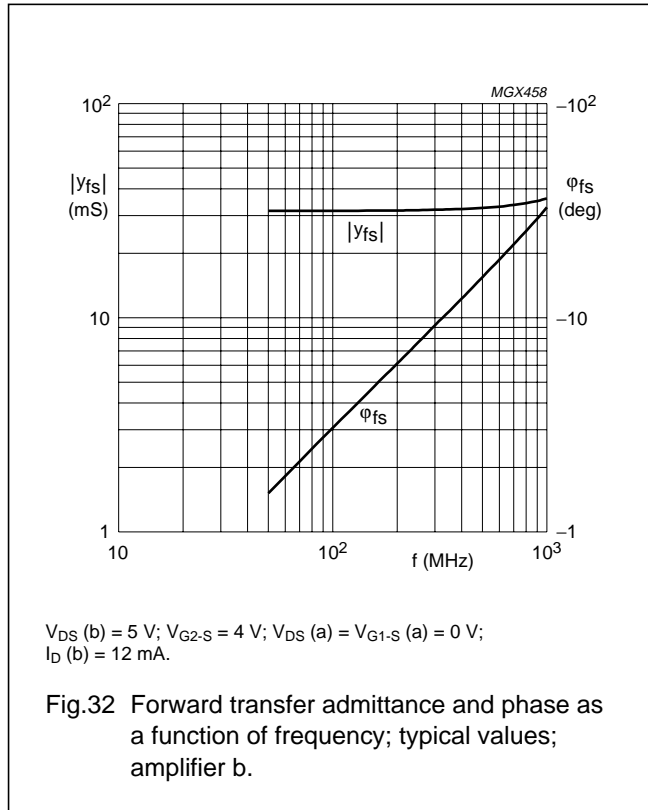
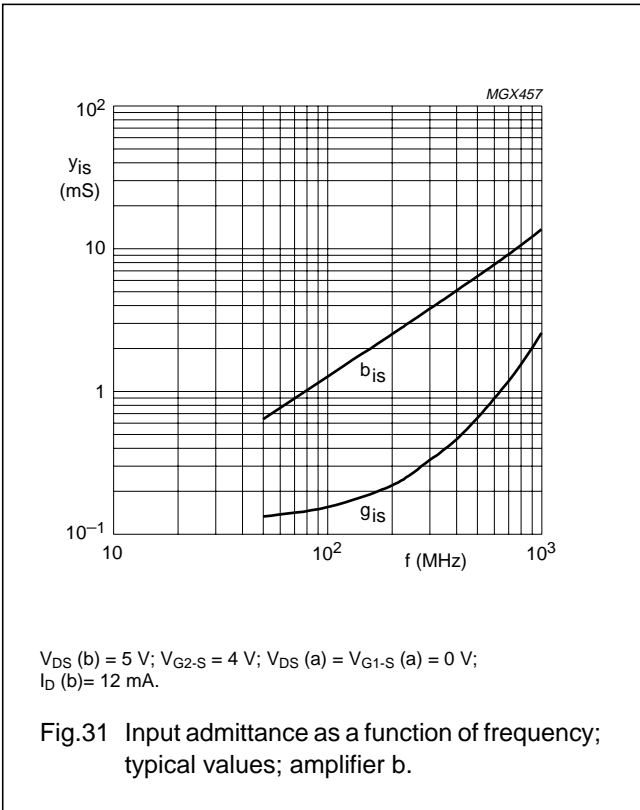
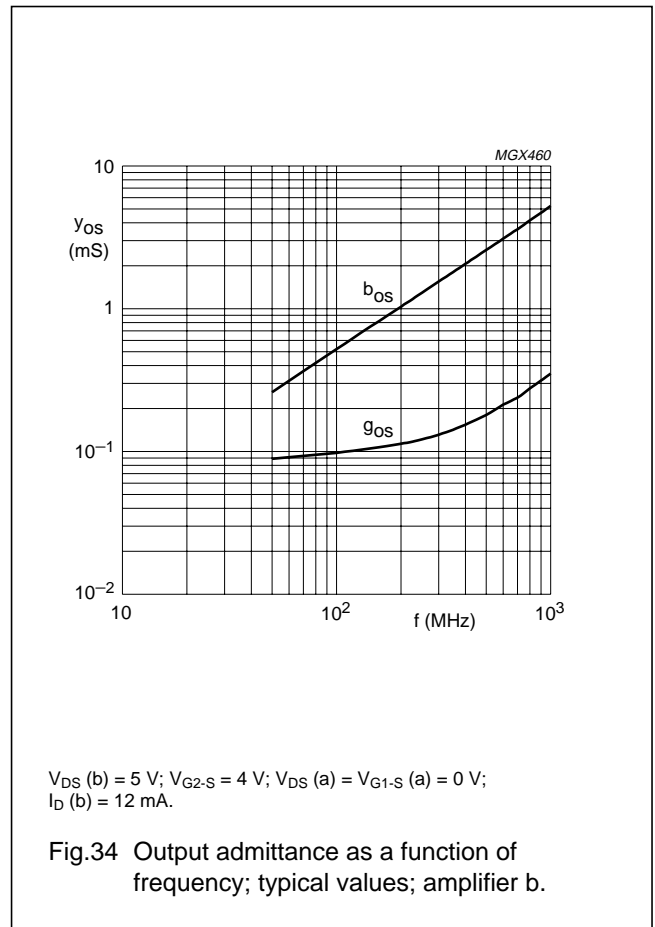
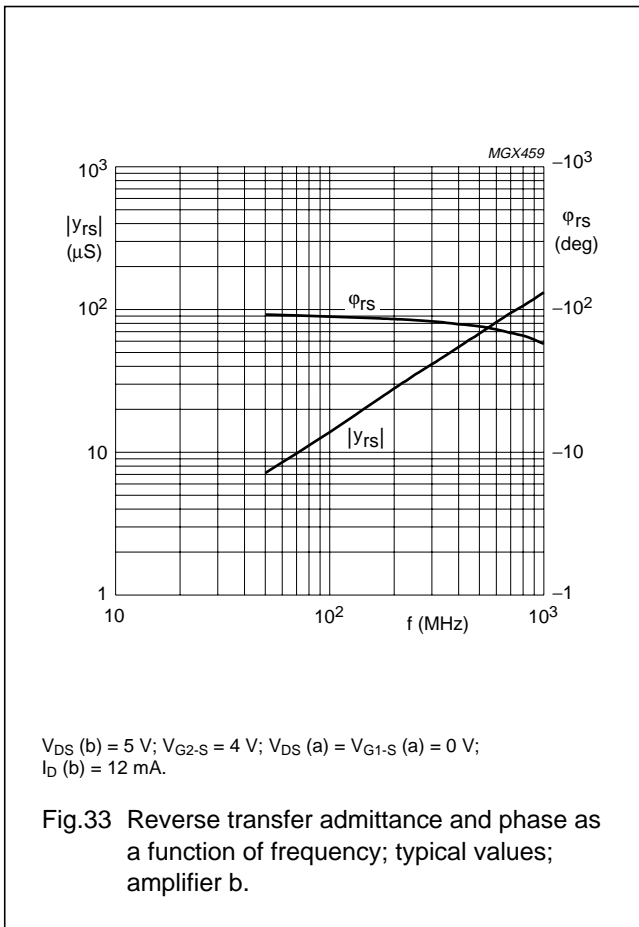


Fig.30 Cross-modulation test set-up for amplifier b.



Dual N-channel dual gate MOS-FET

BF1205



Dual N-channel dual gate MOS-FET

BF1205

Scattering parameters: amplifier b $V_{DS} (b) = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D (b) = 12 \text{ mA}$; $V_{DS} (a) = 0 \text{ V}$; $V_{G1-S} (a) = 0 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) |
| 50 | 0.987 | -3.76 | 3.12 | 175.87 | 0.00071 | 85.43 | 0.991 | -1.56 |
| 100 | 0.985 | -7.38 | 3.11 | 171.77 | 0.00136 | 86.06 | 0.989 | -3.11 |
| 200 | 0.978 | -14.63 | 3.09 | 163.72 | 0.00272 | 84.25 | 0.988 | -6.16 |
| 300 | 0.968 | -21.82 | 3.06 | 155.67 | 0.00396 | 82.63 | 0.986 | -9.17 |
| 400 | 0.956 | -28.92 | 3.01 | 147.79 | 0.00509 | 81.35 | 0.983 | -12.17 |
| 500 | 0.941 | -35.99 | 2.95 | 139.86 | 0.00616 | 79.46 | 0.973 | -15.16 |
| 600 | 0.924 | -42.93 | 2.89 | 132.06 | 0.00710 | 78.57 | 0.975 | -18.15 |
| 700 | 0.905 | -49.89 | 2.83 | 124.31 | 0.00791 | 77.88 | 0.972 | -21.07 |
| 800 | 0.884 | -56.57 | 2.75 | 116.69 | 0.00848 | 76.72 | 0.968 | -24.08 |
| 900 | 0.861 | -63.36 | 2.67 | 108.97 | 0.00900 | 76.55 | 0.964 | -27.03 |
| 1000 | 0.837 | -70.05 | 2.59 | 101.39 | 0.00941 | 76.67 | 0.959 | -30.02 |

Noise data $V_{DS} (b) = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D (b) = 12 \text{ mA}$; $V_{DS} (a) = 0 \text{ V}$; $V_{G1-S} (a) = 0 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$

| f (MHz) | F MIN (dB) | F MIN (dB) | | R _n (Ω) |
|------------|---------------|---------------|-------|--------------------------------|
| | | (ratio) | (deg) | |
| 400 | 1.3 | 0.662 | 16.76 | 31.55 |
| 800 | 1.4 | 0.578 | 33.97 | 30.53 |

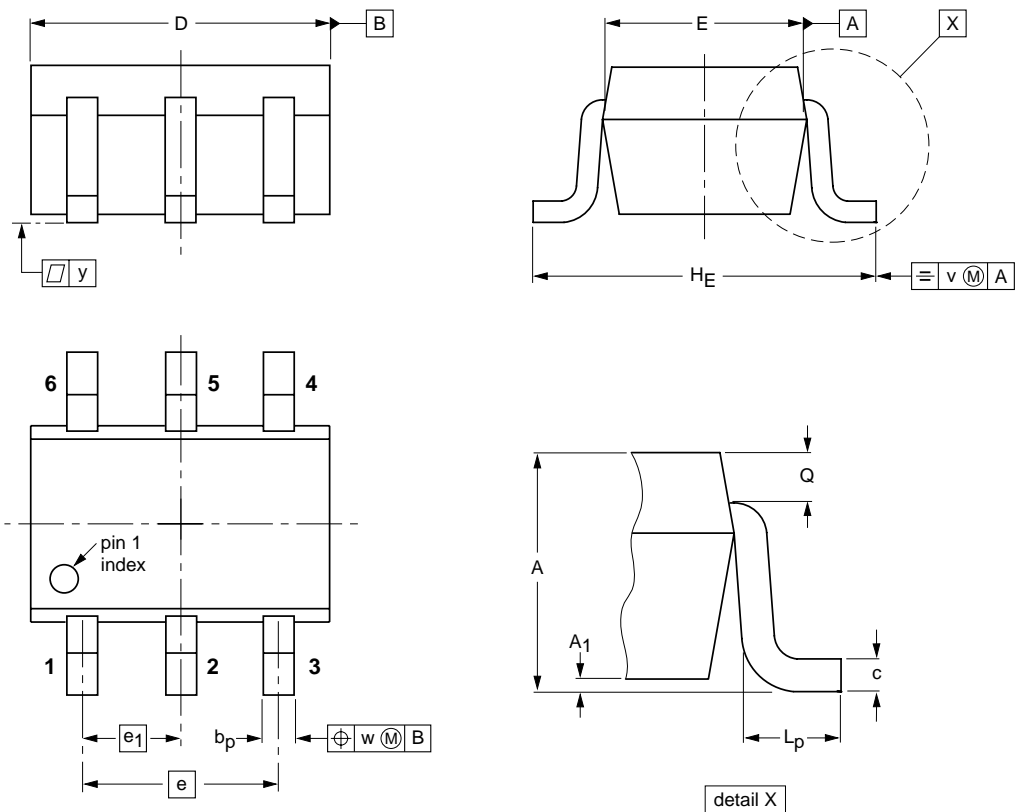
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PACKAGE OUTLINE

Plastic surface mounted package; 6 leads

SOT363



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|-----------------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.30 0.20 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 0.65 | 2.2 2.0 | 0.45 0.15 | 0.25 0.15 | 0.2 | 0.2 | 0.1 |

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|-------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT363 | | | SC-88 | | | 97-02-28 |

Dual N-channel dual gate MOS-FET

BF1205

DATA SHEET STATUS

| LEVEL | DATA SHEET STATUS ⁽¹⁾ | PRODUCT STATUS ⁽²⁾⁽³⁾ | DEFINITION |
|-------|----------------------------------|----------------------------------|--|
| I | Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice. |
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